# FCC PART 15.109 MEASUREMENT AND TEST REPORT FOR

## **J&W TECHNOLOGY LIMITED**

Floor 13, Block B, Haisong Building, Tairan 9<sup>th</sup> Road, Futian District,

Shenzhen, China

FCC ID: WMFJWHERON

Report Concerns:	Equipment Type:		
Original Report	Motherboard		
Model:	JRS780ITX01		
Report No.:	STR08088035I		
Test/Witness Engineer:	John Elii		
Test Date:	<u>2008-08-10-2008-08-15</u>		
Issued Date:	2008-08-22		
Prepared By:			
3/F, Jinbao Commo	ance Service Co., Ltd. erce Building, Xin'an Fanshen Road, enzhen, P.R.C. (518101)		
Approved & Authorized By:	Jandy So /PSQ Manager		

Note: This test report is limited to the above client company and the product model only. It may not be duplicated without prior permitted by SEM.Test Compliance Service Co., Ltd.

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## 1. GENERAL INFORMATION

## 1.1 Product Description for Equipment Under Test (EUT)

**Client Information** 

Applicant: J&W TECHNOLOGY LIMITED

Address of applicant: Floor 13, Block B, Haisong Building, Tairan 9<sup>th</sup> Road, Futian

District, Shenzhen, China

Manufacturer: J&W TECHNOLOGY LIMITED

Address of manufacturer: Floor 13, Block B, Haisong Building, Tairan 9<sup>th</sup> Road, Futian

District, Shenzhen, China

## **General Description of E.U.T**

Items	Description			
EUT Description:	Motherboard			
Trade Name:	JW			
Model No.:	JRS780ITX01			
Rate Power:	95W			
Rate Voltage:	AC120V/60Hz Switching Power Supply			
Size: 17.5 x17.6 x4.3 cm				
For more information refer to the circuit diagram form and the user's manual.				

The test data is gathered from a production sample, provided by the manufacturer.

## 1.2 Test Standards

The following report is prepared on behalf of the J&W TECHNOLGY LIMITED accordance with Part 2, Subpart J, and Part 15, Subparts A and B of the Federal Communication Commissions rules.

The objective is to determine compliance with FCC Part 15, Subpart B, and section 15.107, and 15.109 rules.

Maintenance of compliance is the responsibility of the manufacturer. Any modification of the product, which result in lowering the emission/immunity, should be checked to ensure compliance has been maintained.

## 1.3 Related Submittal(s)/Grant(s)

No Related Submittal(s).

## 1.4 Test Methodology

All measurements contained in this report were conducted with ANSI C63.4-2003, American National Standard for Methods of Measurement of Radio-Noise Emissions from Low-Voltage Electrical and Electronic Equipment in the range of 9 kHz to 40 GHz.

The equipment under test (EUT) was configured to measure its highest possible immunity level. Test is carried with playing mode which worst case has been showed. Test setup was adapted accordingly in reference to the Operating Instructions.

## 1.5 Test Facility

The Laboratory has been registered and fully described in a report filed with the (**FCC**) Federal Communications Commission. The acceptance letter from the FCC is maintained in files which the Registration No.: **994117**. Measurement required was performed at laboratory of SEM.Test Compliance Service Co., Ltd. at 3/F, Jinbao Commerce Building, Xin'an Fanshen Road, Bao'an District, Shenzhen, P.R.C. (518101).

## 1.6 Accessories Equipment List and Details

Manufacturer	Description	Model	Serial Number
TP-LINK	Modem	TM-EC5658V	KT99CTQC-508
Lenovo	Printer	3110	OD65133711480
HUASHENG	Earphone	B12-3	200423154
Lenovo	Mouse	M-UAE119	LZ7300E00G2
Lenovo	Keyboard	LXB-CH0507	07G00500359D
Great wall	Switch power supply	ATX-350P4	2704101570
Seagate	Hard disk driver	320Gbytes	6QF3HWKM

## 1.7 EUT Cable List and Details

Cable Description Length (M)		Shielded/Unshielded	With Core/Without Core	
/	/	/	/	

## 2. SUMMARY OF TEST RESULTS

Description of Test	Result
§15.107 (a) Conducted Emission	Compliant
§15.109(a) Radiated Emission	Compliant

## 3. §15.107 (a)- CONDUCTED EMISSION

## 3.1 Measurement Uncertainty

Base on NIS 81, The Treatment of Uncertainty in EMC Measurements, the best estimate of the uncertainty of any conducted emissions measurement is  $\pm$  1.5dB.

## 3.2 Test Equipment List and Details

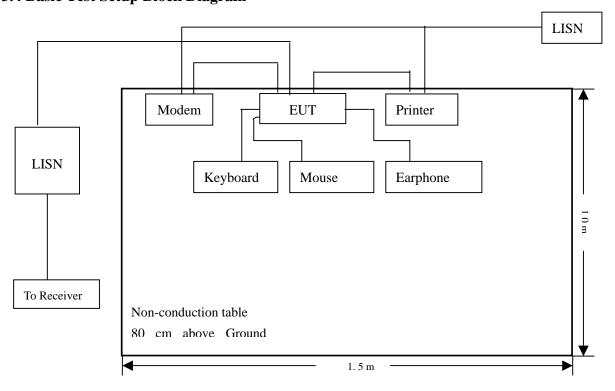
Description	Manufacturer	Model	Serial Number	Cal. Date	Due. Date
Spectrum Analyzer	Agilent	E4402B-ESA	US41192821	2008-01-25	2009-01-24
EMI Test Receiver	ROHDE&SCHW ARZ	ESPI	101206	2008-01-25	2009-01-24
L.I.S.N.	SCHWARZBEC K	NSLK8126	8126-224	2008-01-25	2009-01-24
L.I.S.N.	EMCO	3825/2	11967C	2008-01-25	2009-01-24

## 3.3 Test Procedure

The setup of EUT is according with per ANSI C63.4-2003 measurement procedure. The specification used was with the FCC Part 15.107 Limit.

The external I/O cables were draped along the test table and formed a bundle 30 to 40 cm long in the middle. The spacing between the peripherals was 10 cm.

## 3.4 Basic Test Setup Block Diagram



## 3.5 Environmental Conditions

Temperature:	25° C
Relative Humidity:	55%
ATM Pressure:	1010 mbar

## 3.6 Summary of Test Results/Plots

According to the data in section 3.7, the EUT <u>complied with the FCC 15B</u> Conducted margin for a Class B device, with the *worst* margin reading of:

## -11.1 dB $\mu V$ at 0.49 MHz in the Neutral mode, Average detector, 0.15-30MHz

## 3.7 Conducted Emissions Test Data

	LINE COND	FCC 15B	CLASS B		
Frequency	Amplitude	Detector	Phase	Limit	Margin
MHz	dΒμV	QP/Ave/Pk	Line/Neutral	dBμV	dB
0.49	35.10	Ave	Neutral	46.17	-11.1
1.95	32.50	Ave	Neutral	46	-13.5
3.42	30.50	Ave	Line	46	-15.5
8.79	32.70	Ave	Line	50	-17.3
0.27	30.00	Ave	Neutral	51	-21.0
0.395	36.58	QP	Neutral	57.96	-21.4
0.39	36.20	QP	Line	58.06	-21.9
1.138	33.50	QP	Neutral	56	-22.5
1.31	31.20	QP	Neutral	56	-24.8
20.51	20.20	Ave	Line	50	-29.8
6.71	29.10	QP	Line	60	-30.9
5.41	28.90	QP	Line	60	-31.1

## **Plot of Conducted Emissions Test Data**

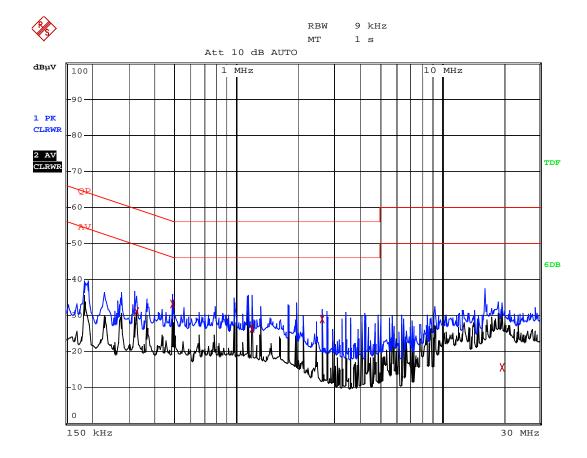
 $Conducted\ Disturbance$ 

EUT: Motherboard M/N: JRS780ITX01

Operating Condition: Running

Test Specification: L

Comment: AC120V/60Hz Switch Power Supply



Date: 13.AUG.2008 18:11:55

## **Plot of Conducted Emissions Test Data**

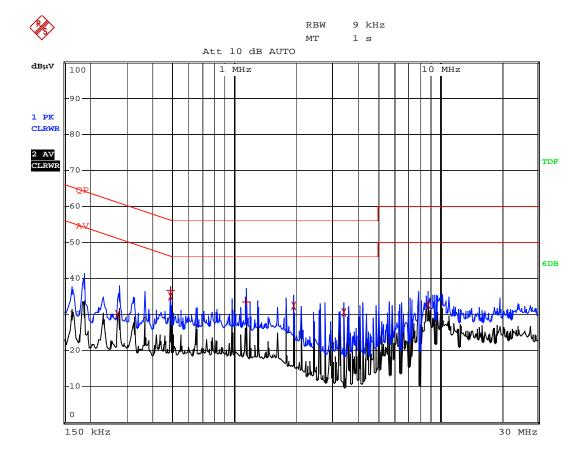
 $Conducted\ Disturbance$ 

EUT: Motherboard M/N: JRS780ITX01

Operating Condition: Running

Test Specification: N

Comment: AC120V/60Hz Switch Power Supply



Date: 13.AUG.2008 18:10:41

## 4. §15.109(a)- RADIATED EMISSION

## **4.1 Measurement Uncertainty**

Base on NIS 81, The Treatment of Uncertainty in EMC Measurements, the best estimate of the uncertainty of any radiation emissions measurement is  $\pm$  3.0 dB.

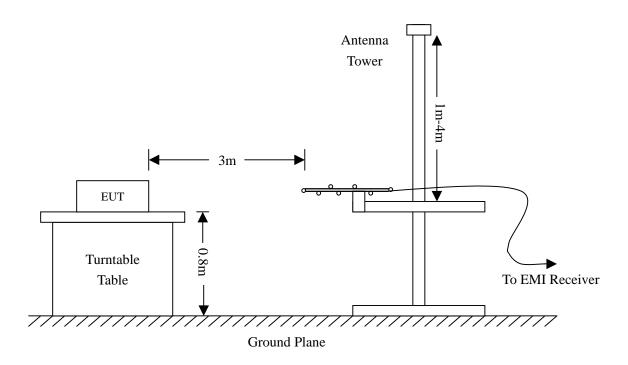
## 4.2 Test Equipment List and Details

Manufacturer	Description	Model	Serial Number	Cal. Date	Due. Date
Spectrum Analyzer	ROHDE&SCHWARZ	FSEA20	DE25181	2008-01-25	2009-01-24
Positioning Controller	C&C	CC-C-1F	N/A	2008-01-25	2009-01-24
Trilog Broadband Antenna	SCHWARZBECK	VULB9163	9163-333	2008-01-25	2009-01-24
Horn Antenna	SCHWARZBECK	BBHX 9120	9120-426	2008-01-25	2009-01-24
RF Switch	EM	EMSW18	SW060023	2008-01-25	2009-01-24
Amplifier	Agilent	8447F	3113A06717	2008-01-25	2009-01-24
Coaxial Cable	SCHWARZBECK	AK9513	9513-10	2008-01-25	2009-01-24
EMI Test Receiver	ROHDE&SCHWARZ	ESPI	25498514	2008-01-25	2009-01-24

## **4.3 Test Procedure**

The setup of EUT is according with per ANSI C63.4-2003 measurement procedure. The specification used was with the FCC Part 15.109 Limit.

The external I/O cables were draped along the test table and formed a bundle 30 to 40 cm long in the middle. The spacing between the peripherals was 10 cm.



## 4.4 Corrected Amplitude & Margin Calculation

The Corrected Amplitude is calculated by adding the Antenna Factor and the Cable Factor, and subtracting the Amplifier Gain from the Amplitude reading. The basic equation is as follows:

The "Margin" column of the following data tables indicates the degree of compliance with the applicable limit. For example, a margin of  $-6dB\mu V$  means the emission is  $6dB\mu V$  below the maximum limit for Class B. The equation for margin calculation is as follows:

#### **4.5 Environmental Conditions**

Temperature:	25° C
Relative Humidity:	52%
ATM Pressure:	1012 mbar

## 4.6 Summary of Test Results/Plots

According to the data in section 4.6, the <u>EUT complied with the FCC 15 Class B</u> standards, and had the worst margin is:

-3.41 dBµV at 1416.834 MHz in the, Vertical polarization, 30 MHz to 18 GHz, 3Meters

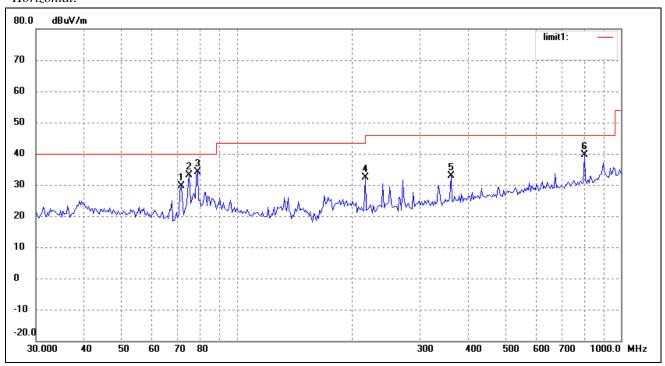
## **Plot of Radiation Emissions Test Data**

Radiated Emission EUT: Motherboard M/N: JRS780ITX01

Operating Condition: Running

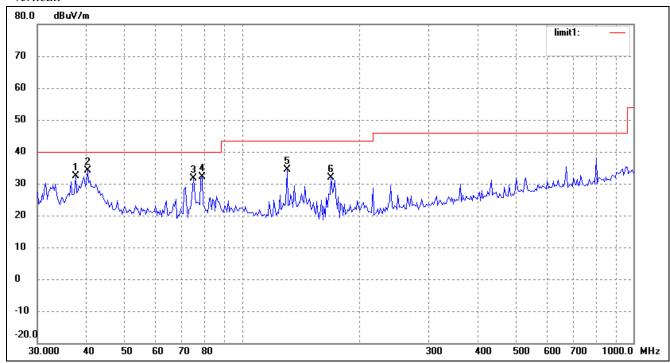
Test Specification: Horizontal & Vertical Comment: AC120V/60Hz Switch Power Supply

## Horizontal:



No.	Frequency	Reading	Correct	Result	Limit	Margin	Degree	Height	Remark
	(MHz)	(dBuV/m)	Factor(dB)	(dBuV/m)	(dBuV/m)	(dB)	(°)	(cm)	
1	71.7054	26.22	3.35	29.57	40.00	-10.43	45	100	peak
2	75.3208	30.16	2.90	33.06	40.00	-6.94	39	120	peak
3	79.1185	30.54	3.48	34.02	40.00	-5.98	162	114	QP
4	216.1197	25.34	7.15	32.49	46.00	-13.51	320	146	peak
5	360.9775	21.92	10.90	32.82	46.00	-13.18	225	112	peak
6	804.2523	23.96	15.57	39.53	46.00	-6.47	98	121	peak

## Vertical:



No.	Frequency	Reading	Correct	Result	Limit	Margin	Degree	Height	Remark
	(MHz)	(dBuV/m)	Factor(dB)	(dBuV/m)	(dBuV/m)	(dB)	(°)	(cm)	
1	37.5648	24.95	7.48	32.43	40.00	-7.57	360	120	peak
2	40.2995	26.04	8.15	34.19	40.00	-5.81	15	109	QP
3	75.3208	28.79	2.90	31.69	40.00	-8.31	26	113	peak
4	79.1185	28.74	3.48	32.22	40.00	-7.78	21	100	peak
5	130.3048	29.81	4.54	34.35	43.50	-9.15	64	110	peak
6	168.9970	26.95	4.85	31.80	43.50	-11.70	200	100	peak

## Radiation Emission (Above 1GHz)

Pol.	Frequency	Reading	Correct	Result	Limit	Margin	Degree	Height	Remark
	(MHz)	(dBuV/m)	Factor(dB)	(dBuV/m)	(dBuV/m)	(dB)	(°)	(cm)	
V	1064.128	31.86	16.32	48.18	54.00	-5.82	360	100	peak
V	1416.834	31.88	18.71	50.59	54.00	-3.41	150	100	peak
Н	1629.258	25.58	20.48	46.06	54.00	-7.94	243	100	peak
V	1829.659	27.36	22.39	49.75	54.00	-4.25	222	100	peak
Н	2130.260	23.66	23.94	47.60	54.00	-6.40	16	100	peak
V	2659.319	20.56	28.03	48.59	54.00	-5.41	120	100	peak

Note: For above 1GHz frequency radiated emission testing, the emissions are close base noise not report.

## \*\*\*\*\* END OF REPORT \*\*\*\*\*